

FORM PTO 1449 (modified)		ATTY DOCKET NO. 03560.003310		APPLICATION NO. 10/601,777	
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)		APPLICANT Tadashi Okamoto et al.			
		FILING DATE Jun 24, 2003		GROUP 1631 NYA	

U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
EDJ	5,405,783	04/11/95	Pirrung et al.	436	518	
↓	5,601,980	02/11/97	Gordon et al.	435	6	
↓	6,384,237 B1	05/07/02	Suzuki et al.	549	13	
↓	6,476,215 B1	11/05/02	Okamoto et al.	536	25.3	

FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
EDJ	JP	11-187900	07/13/99	Japan	—	—	Abstract

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)	
EDJ	Mark Schena et al., "Quantitative Monitoring of Gene Expression Patterns with a Complementary DNA Microarray," 270 Science 467-470 (October 1995).
↓	H.F. Arlinghaus et al., "TOF-SIMS Characterization of DNA and PNA Biosensor Chips," Proceedings of the 12 th International Conference on Secondary Ion Mass Spectrometry, pp. 951-954 (September 1999).

EXAMINER <i>Eun De Joo</i>	DATE CONSIDERED 05/13/05
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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